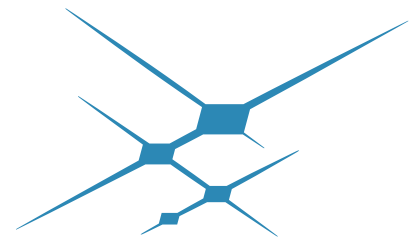


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Enhancing Data Integrity and Reliability of Smart Metering Solutions with CMOS Digital Isolators

The automated meter reading (AMR) market is projected to grow by double digits over the next several years as consumers upgrade from traditional electromechanical meters to grid-connected smart meters. Today's sophisticated smart meters use the latest integrated circuit (IC) technology to accurately measure and report the amount of power consumed. Although smart meters are more sophisticated than electromechanical power meters, a primary concern in smart meter design is measurement data integrity, which can directly impact the utility provider's billing revenue. System reliability is another major concern as poor reliability negatively impacts the utility provider through increased repair and replacement costs. The most effective solutions for ensuring data integrity and long term system reliability in smart meter designs is the use of state-of-the-art digital isolation technology.

Smart power meters use galvanic isolation to protect internal low-voltage integrated circuits, as well as utility service personnel, from the sensors exposed to the high-voltage mains. In wired metering applications, such as those deployed in high-density residential complexes, isolation also may be used between the controller and the digital data bus, as shown in Figure 1.

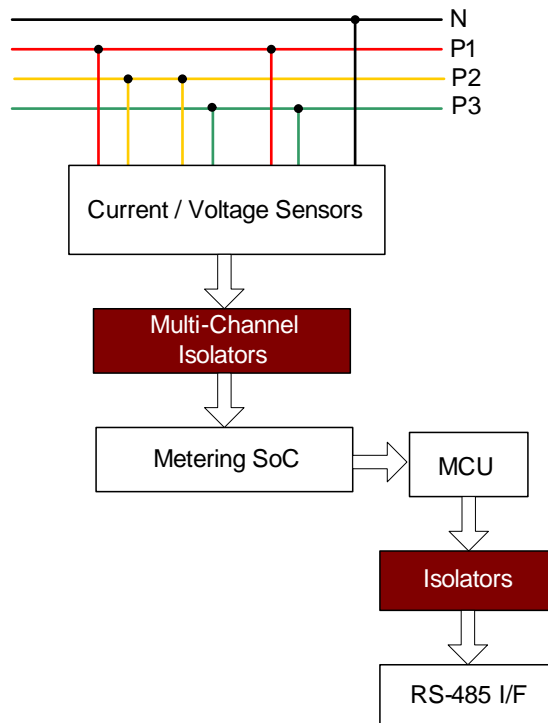


Figure 1. Smart Power Meter with Digital Communications Bus

Other subsystems, especially those that are exposed to high voltages, also must contain isolation circuitry. For instance, galvanic isolation is necessary between an internal smart meter controller IC and a power line communications (PLC) modem. Signal isolation in these systems may be implemented in a number of ways.

Optocouplers are often used in smart meters for signal isolation, but their usage presents design challenges. In particular, optocouplers do not provide a reliable isolation solution for the long term. The performance level of these devices inherently varies over time due to the dielectric material used

for isolation and the LED used as the internal signal transmitter. The clarity of the isolation barrier can degrade over time and is subject to a variety of environmental factors such as temperature and humidity. In addition, all LEDs experience a reduction in signal strength with time. These two factors limit the length of time that an optocoupler-based smart meter can reliably remain in service.

Another significant drawback of optocouplers is their limited common mode transient immunity (CMTI). CMTI is a measure of the isolator's ability to reject fast transient noise signals that are present between the input and the output sides of the isolation barrier. Because of their physical structure, optocouplers tend to have high parasitic input-output capacitance (typically in picofarads). Higher internal parasitic coupling capacitance results in poorer CMTI performance (see Figure 2).

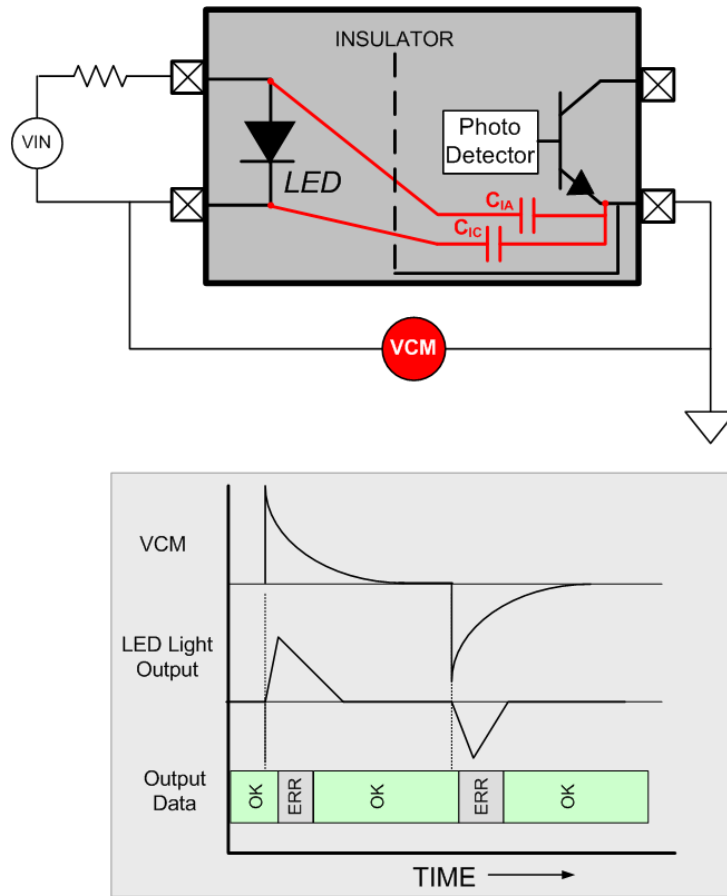


Figure 2. Common Mode Transients Affect Optocoupler Signals, Causing Data Errors

Optocoupler suppliers often recommend overdriving the optocoupler's LED to increase noise immunity when on, and reverse-biasing the LED for added immunity when off. These actions increase optocoupler CMTI, but they further decrease the device lifetime. System reliability is negatively affected and maintenance costs increase.

Another isolation solution for smart power meter applications involves the use of an isolation transformer. However, transformers are generally avoided because of their susceptibility to data-corrupting electromagnetic interference (EMI). Pulse transformers multiply this concern because of their inherently wider bandwidth, which is necessary to faithfully convey digital signals.

Electromagnetic (EM) immunity is a primary concern in power meter designs for two reasons. First, there is a high probability that the meter will be installed in an electromagnetically noisy location.

Second, some isolation techniques are potentially the weakest point in the meter system for exploitation. For example, the application of an external field to a transformer-based system can negatively impact data integrity. Indeed, there have been cases of utility customers disabling power meters by attaching strong magnets or coils to the equipment. In either case, the external magnetic field or EM noise will present false measurement data to the controller.

Modern CMOS digital isolators address these concerns in smart meter applications. Compared to optocouplers, CMOS-based digital isolators deliver substantially higher CMTI performance while maintaining higher operating lifetimes and greater reliability. For example, Silicon Labs' Si86xx family of CMOS digital isolators has a typical CMTI specification of 60 kV/μs, and next-generation isolation devices are expected to double this performance level.

CMOS digital isolators are vastly superior to alternative isolation technologies in terms of electromagnetic performance. The Si86xx isolators, for example, exhibit the highest EMI tolerance (>300 V/m E-field immunity, and >1000 A/m magnetic field immunity) of all commercially-available digital isolation devices. These digital isolators achieve this performance by using a differential signal path to transmit data across the isolation barrier. Paired with narrow pass-band filtering, this provides superior common mode noise rejection, as shown in Figure 3.

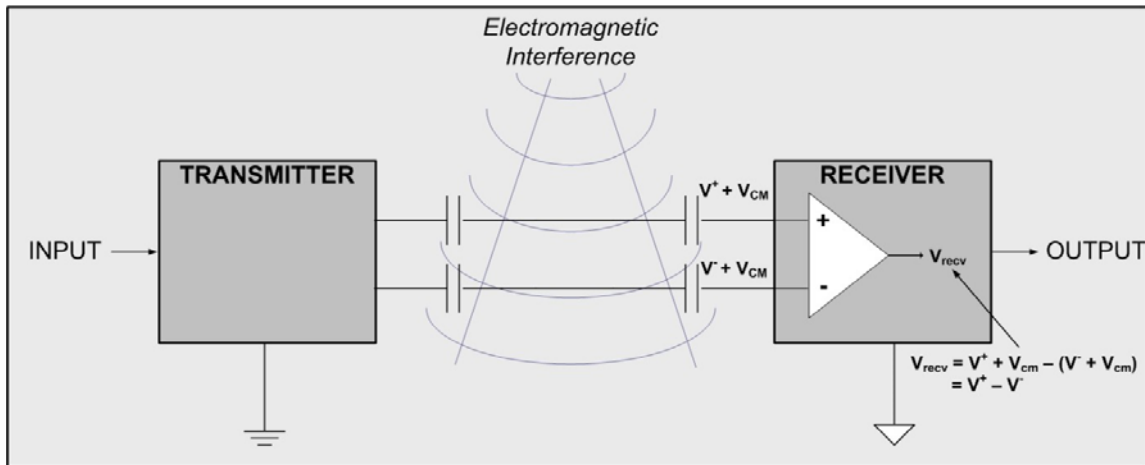


Figure 3. Differential Signals and Narrowband Receiver Reject Common Mode Noise

Superior electromagnetic interference and CMTI performance stems from the fact that a CMOS-based isolator implementation minimizes device feature sizes. Minimal capacitor dimensions reduce both the intentional and the parasitic capacitances across the isolation barrier. This boosts the CMTI performance over solutions with high capacitance across the barrier. Small feature size also helps prevent the isolator from acting as an antenna for stray fields. Along with avoiding the use of transformers in the design, this characteristic enables the system to maintain a high level of electromagnetic immunity.

The long-term reliability and functional lifetime of CMOS digital isolators are decidedly superior to other traditional isolation solutions. The dielectric material used in digital isolators is often a highly stable silicon dioxide (SiO₂) layer produced as a standard CMOS processing step. Silicon dioxide demonstrates no degradation due to environment affects and does not show changes in its inherent properties over time. The internal signal sources are completely electrical and do not change properties over time, either. CMOS digital isolators, under worst case conditions of high temperature and a constant isolation barrier voltage of hundreds of volts, are expected to perform reliably over 60 years. Indeed, CMOS digital isolators should outlast the usable lifetime of the system and reduce repair and replacement costs.

As smart metering becomes more prevalent in the market with the worldwide build-out of the smart grid, meter installers will become less discriminating about the environments in which the meters are located, increasing the probability of measurement data corruption. Any metering component used in

the meter design that can be adversely affected by electrical noise or electromagnetic fields must be considered to be a weak link in the overall integrity of the system. These components have the potential to disrupt data to the smart meter controller and ultimately invalidate the utility's billing information.

The growing installed base of smart metering solutions means that long-term system reliability must always be a top concern. As with any complex system, overall reliability is limited by the weakest component in the system. In many cases, the weak link will be an inferior, antiquated isolation technology. Moving to modern, CMOS-based digital isolation products eliminates concerns about the lifetime of the isolation portion of the smart meter design. Improving the system lifetime ultimately reduces repair costs and warranty expenses.

Despite the popularity of optocouplers and transformers as isolation technologies, both of these solutions have tangible weaknesses that should cause concern for metering applications. CMOS digital isolators offer the optimal isolation solution for smart metering by providing superior immunity to electrical noise and external fields. Using CMOS digital isolators in smart metering ensures that accurate, uncorrupted power measurement data passes across the isolation barrier to the system controller.

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